

Notice of References Cited	Application/Control No. 10/667,079	Applicant(s)/Patent Under Reexamination TSENG ET AL.	
	Examiner Gelek Topgyal	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,483,296	01-1996	Nonweiler, Brian	348/719
*	B	US-6,728,477	04-2004	Watkins, Daniel	386/125
*	C	US-6,285,804	09-2001	Crinon et al.	382/299
*	D	US-6,944,392	09-2005	De Bruijne, Roeland Pieter	386/125
*	E	US-6,573,819	06-2003	Oshima et al.	386/111
*	F	US-6,925,250	08-2005	Oshima et al.	386/111
*	G	US-7,024,102	04-2006	Inoshita et al.	386/111
*	H	US-6,415,101	07-2002	deCarmo et al.	386/105
*	I	US-6,429,895	08-2002	Onuki, Ichiro	348/208.99
*	J	US-6,185,369	02-2001	Ko et al.	386/125
*	K	US-5,430,486	07-1995	Fraser et al.	348/426.1
*	L	US-6,125,201	09-2000	Zador, Andrew Michael	382/166
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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